Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/619,128	WAIN ET AL.
Examiner	Art Unit
Andrew Y. Chou	2192

Applicant(s)/Patent under Reexamination
WAIN ET AL.
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EAST Text Search	2/B/2N7, 2/14/2N7, 2/26/207	AYC
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